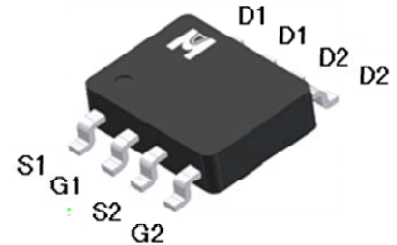
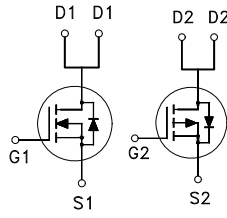


N & P-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

	N-CH	P-CH
BV _{DSS}	30V	-30V
R _{DS(on)} (MAX.)	21mΩ	50mΩ
I _D	8A	-5A



UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS		UNIT
Gate-Source Voltage		V _{GS}	N-CH	P-CH	V
			±20	±20	
Continuous Drain Current	T _A = 25 °C	I _D	8	-5	A
	T _A = 70 °C		6.4	-4	
Pulsed Drain Current ¹		I _{DM}	32	-20	
Avalanche Current		I _{AS}	10	-10	
Avalanche Energy	L = 0.1mH, I _D =10A, R _G =25Ω (N) L = 0.1mH, I _D =-10A, R _G =25Ω (P)	E _{AS}	5	5	mJ
Repetitive Avalanche Energy ²	L = 0.05mH	E _{AR}	2.5	2.5	
Power Dissipation	T _A = 25 °C	P _D	2		W
	T _A = 70 °C		1.28		
Operating Junction & Storage Temperature Range		T _j , T _{stg}	-55 to 150		°C

100% UIS testing in condition of V_D=15V, L=0.1mH, V_G=10V, I_L=6A, Rated V_{DS}=30V N-CH

100% UIS testing in condition of V_D=15V, L=0.1mH, V_G=-10V, I_L=-6A, Rated V_{DS}=-30V P-CH

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	R _{θJC}		25	°C / W
Junction-to-Ambient ³	R _{θJA}		62.5	

¹Pulse width limited by maximum junction temperature.

²Duty cycle $\leq 1\%$

³62.5°C / W when mounted on a 1 in² pad of 2 oz copper.

ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT	
			MIN	TYP	MAX		
STATIC							
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	N-CH	30		V	
		V _{GS} = 0V, I _D = -250μA	P-CH	-30			
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	N-CH	1	1.5	3	
		V _{DS} = V _{GS} , I _D = -250μA	P-CH	-1	-1.5	-3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V	N-CH			±100	
		V _{DS} = 0V, V _{GS} = ±20V	P-CH			±100	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 24V, V _{GS} = 0V	N-CH			1	
		V _{DS} = -24V, V _{GS} = 0V	P-CH			-1	
		V _{DS} = 20V, V _{GS} = 0V, T _J = 125 °C	N-CH				25
		V _{DS} = -20V, V _{GS} = 0V, T _J = 125 °C	P-CH				-25
On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 10V, V _{GS} = 10V	N-CH	8		A	
		V _{DS} = -5V, V _{GS} = -10V	P-CH	-5			
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 10V, I _D = 8A	N-CH		17	21	
		V _{GS} = -10V, I _D = -5A	P-CH		40	50	
		V _{GS} = 4.5V, I _D = 5A	N-CH		25	30	
		V _{GS} = -4.5V, I _D = -4A	P-CH		65	80	
Forward Transconductance ¹	g _{fs}	V _{DS} = 5V, I _D = 8A	N-CH		16	S	
		V _{DS} = -5V, I _D = -5A	P-CH		14		
DYNAMIC							
Input Capacitance	C _{iss}	N-CH V _{GS} = 0V, V _{DS} = 15V, f = 1MHz P=CH V _{GS} = 0V, V _{DS} = -15V, f = 1MHz	N-CH		753	pF	
			P-CH		726		
Output Capacitance	C _{oss}		N-CH		81		
			P-CH		90		
Reverse Transfer Capacitance	C _{rss}	N-CH		68			
		P-CH		76			



Gate Resistance	R_g	$V_{GS} = 15mV, V_{DS} = 0V, f = 1MHz$	N-CH	1.2	Ω
			P-CH	4.5	
Total Gate Charge ^{1,2}	$Q_g(V_{GS}=10V)$	N-CH $V_{DS} = 15V, V_{GS} = 10V,$ $I_D = 8A$ P-CH $V_{DS} = -15V, V_{GS} = -10V,$ $I_D = -5A$	N-CH	12	nC
	$Q_g(V_{GS}=-10V)$		P-CH	11.5	
	$Q_g(V_{GS}=4.5V)$		N-CH	6	
	$Q_g(V_{GS}=-4.5V)$		P-CH	5.6	
Gate-Source Charge ^{1,2}	Q_{gs}		N-CH	2.5	
			P-CH	2.5	
Gate-Drain Charge ^{1,2}	Q_{gd}		N-CH	2.2	
			P-CH	2.2	
Turn-On Delay Time ^{1,2}	$t_{d(on)}$	N-CH $V_{DS} = 15V,$ $I_D = 1A, V_{GS} = 10V, R_{GS} = 6\Omega$ P-CH	N-CH	11	nS
			P-CH	10	
Rise Time ^{1,2}	t_r	P-CH $V_{DS} = -15V,$ $I_D = -1A, V_{GS} = -10V, R_{GS} = 6\Omega$	N-CH	16	
			P-CH	10	
Turn-Off Delay Time ^{1,2}	$t_{d(off)}$		N-CH	25	
			P-CH	18	
Fall Time ^{1,2}	t_f		N-CH	20	
			P-CH	15	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ C$)

Continuous Current	I_S		N-CH	2.3	A
			P-CH	-2.3	
Pulsed Current ³	I_{SM}		N-CH	9.2	
			P-CH	-9.2	
Forward Voltage ¹	V_{SD}	$I_F = I_S, V_{GS} = 0V$	N-CH	1.2	V
			P-CH	-1.2	
Reverse Recovery Time	t_{rr}	$I_F = I_S, di_F/dt = 100A / \mu S$	N-CH	15	nS
			P-CH	15	
Reverse Recovery Charge	Q_{rr}		N-CH	3.2	nC
			P-CH	8	

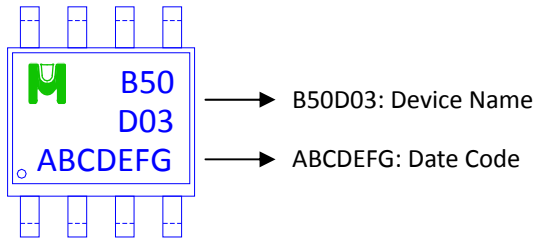
¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

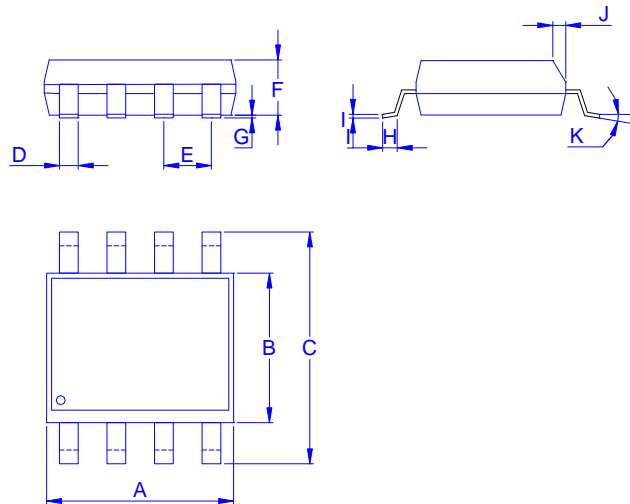
³Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: EMB50D03G for SOP-8



Outline Drawing

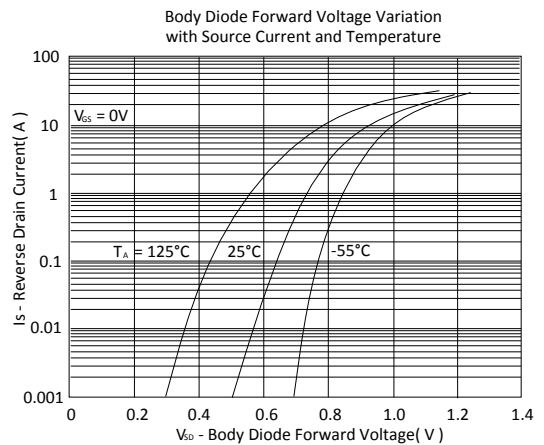
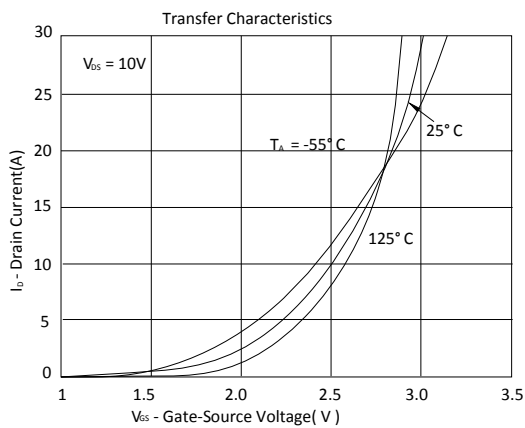
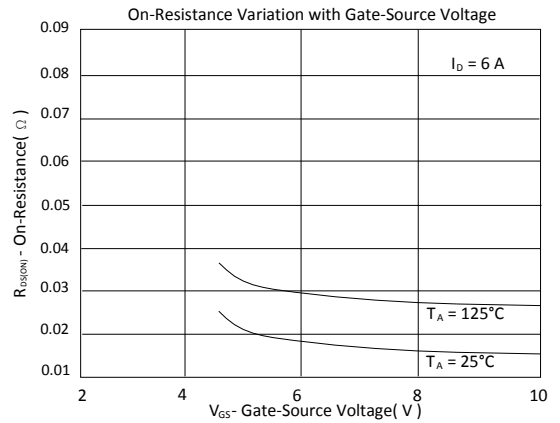
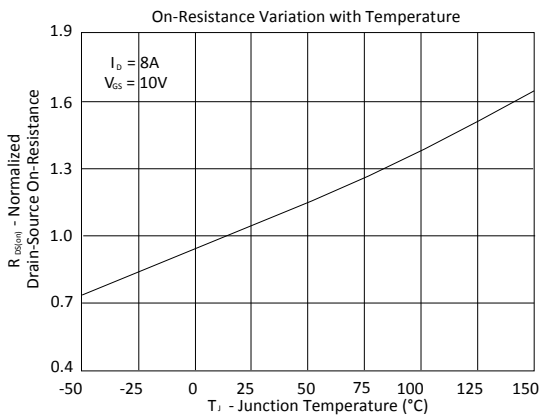
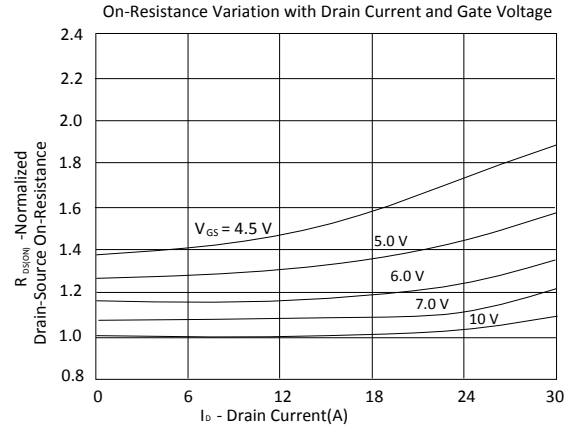
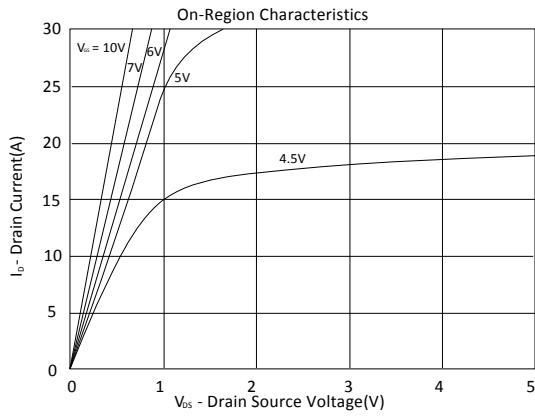


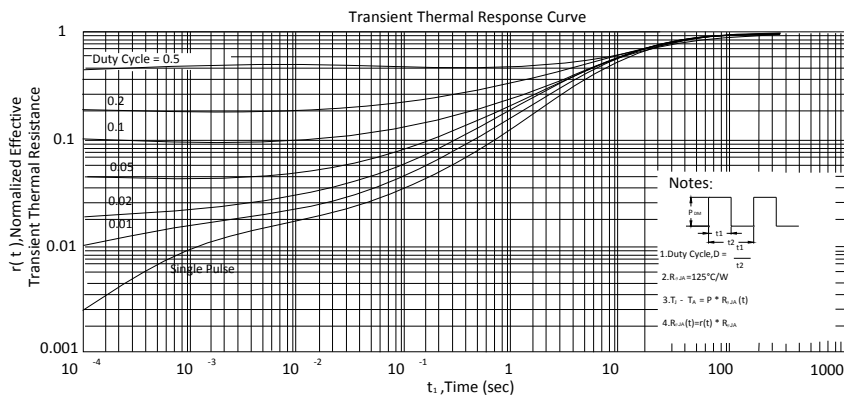
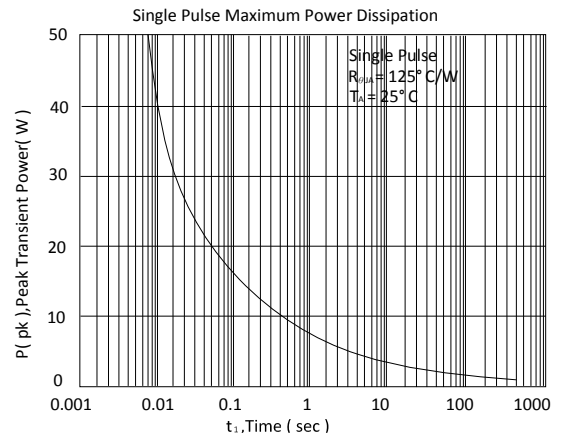
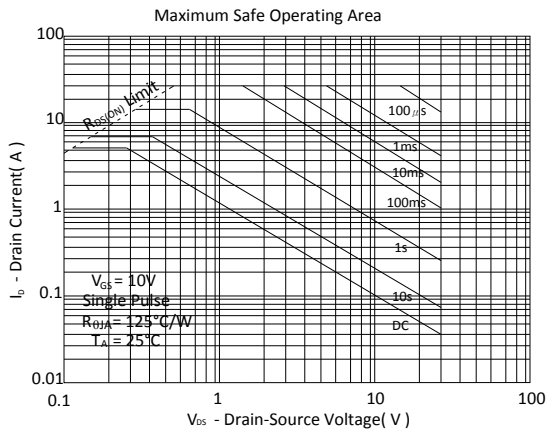
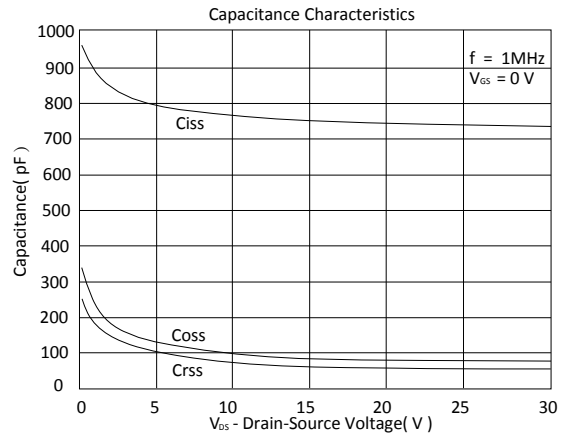
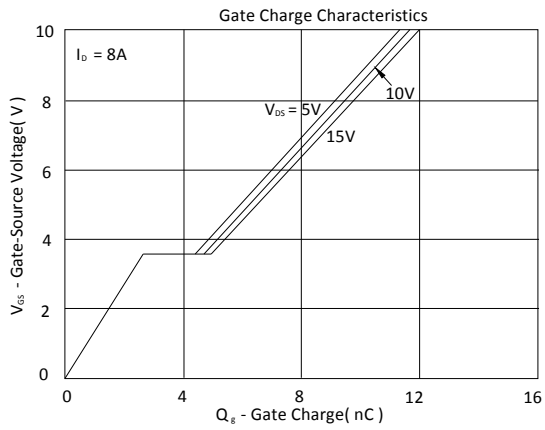
Dimension in mm

Dimension	A	B	C	D	E	F	G	H	I	J	K
Min.	4.70	3.70	5.80	0.33		1.20	0.08	0.40	0.19	0.25	0°
Typ.					1.27						
Max.	5.10	4.10	6.20	0.51		1.62	0.28	0.83	0.26	0.50	8°



N-Channel







P-Channel

